# 74HC245; 74HCT245

Octal bus tranceiver; 3-state

Rev. 03 — 31 January 2005

**Product data sheet** 

#### 1. **General description**

The 74HC245; 74HCT245 is a high-speed Si-gate CMOS device and is pin compatible with Low-Power Schottky TTL (LSTTL).

The 74HC245; 74HCT245 is an octal transceiver featuring non-inverting 3-state bus compatible outputs in both send and receive directions. The 74HC245; 74HCT245 features an output enable input  $(\overline{OE})$  for easy cascading and a send/receive input (DIR) for direction control.  $\overline{OE}$  controls the outputs so that the buses are effectively isolated.

The 74HC245; 74HCT245 is similar to the 74HC640; 74HCT640 but has true (non-inverting) outputs.

#### 2. **Features**

- Octal bidirectional bus interface
- Non-inverting 3-state outputs
- Multiple package options
- Complies with JEDEC standard no. 7A
- ESD protection:
  - ◆ HBM EIA/JESD22-A114-B exceeds 2000 V
  - MM EIA/JESD22-A115-A exceeds 200 V
- Specified from -40 °C to +85 °C and from -40 °C to +125 °C

#### **Quick reference data** 3.

**Quick reference data**  $GND = 0 \ V; \ T_{amb} = 25 \ ^{\circ}C; \ t_{r} = t_{f} = 6 \ ns.$ 

	_									
Symbol	Parameter	Conditions	Min	Тур	Max	Unit				
Type 74HC	2245									
t <sub>PHL</sub> , t <sub>PLH</sub>	propagation delay An to Bn or Bn to An	$C_L = 15 pF;$ $V_{CC} = 5 V$	-	7	-	ns				
C <sub>I</sub>	input capacitance		-	3.5	-	pF				
C <sub>I/O</sub>	input/output capacitance		-	10	-	pF				
C <sub>PD</sub>	power dissipation capacitance per transceiver	$V_I = GND$ to $V_{CC}$	<u>[1]</u> _	30	-	pF				
Type 74HC	Type 74HCT245									
t <sub>PHL</sub> , t <sub>PLH</sub>	propagation delay An to Bn or Bn to An	$C_L = 15 \text{ pF};$ $V_{CC} = 5 \text{ V}$	-	10	-	ns				



Table 1: Quick reference data ...continued

 $GND = 0 \ V; \ T_{amb} = 25 \ ^{\circ}C; \ t_r = t_f = 6 \ ns.$ 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Cı	input capacitance		-	3.5	-	pF
C <sub>I/O</sub>	input/output capacitance		-	10	-	pF
C <sub>PD</sub>	power dissipation capacitance per transceiver	$V_I = GND$ to $V_{CC} - 1.5 V$	<u>[1]</u> -	30	-	pF

[1]  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ):

 $P_D = C_{PD} \times V_{CC}{}^2 \times f_i \times N + \sum{(C_L \times V_{CC}{}^2 \times f_o)}$  where:

 $f_i$  = input frequency in MHz;

f<sub>o</sub> = output frequency in MHz;

C<sub>L</sub> = output load capacitance in pF;

 $V_{CC}$  = supply voltage in V;

N = number of inputs switching;

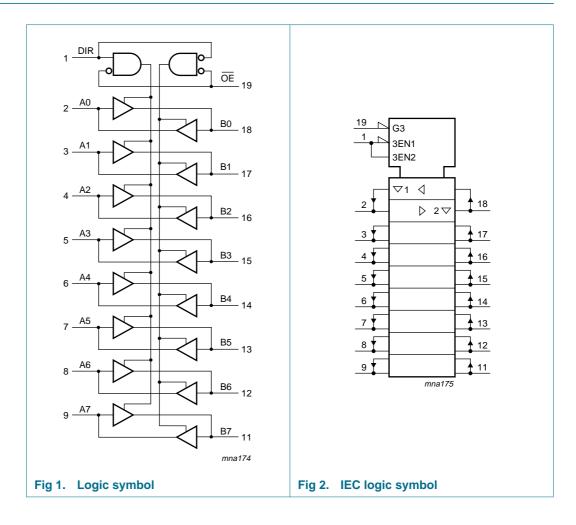
 $\sum (C_L \times V_{CC}^2 \times f_o) = \text{sum of outputs.}$ 

### 4. Ordering information

#### **Table 2: Ordering information**

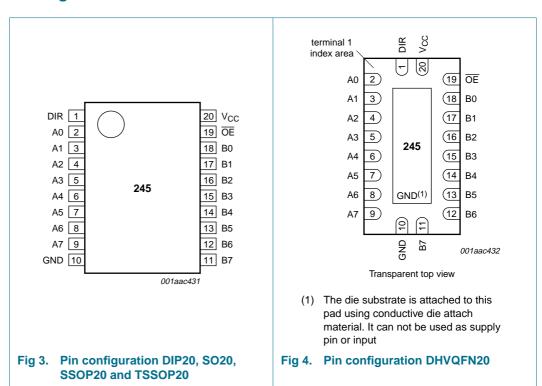
Type number	Package						
	Temperature range	Name	Description	Version			
74HC245N	–40 °C to +125 °C	DIP20	plastic dual in-line package; 20 leads (300 mil)	SOT146-1			
74HC245D	–40 °C to +125 °C	SO20	plastic small outline package; 20 leads; body width 7.5 mm	SOT163-1			
74HC245PW	–40 °C to +125 °C	TSSOP20	plastic thin shrink small outline package; 20 leads; body width 4.4 mm	SOT360-1			
74HC245DB	–40 °C to +125 °C	SSOP20	plastic shrink small outline package; 20 leads; body width 5.3 mm	SOT339-1			
74HC245BQ	–40 °C to +125 °C	DHVQFN20	plastic dual-in-line compatible thermal enhanced very thin quad flat package no leads; 20 terminals; body $2.5\times4.5\times0.85$ mm	SOT764-1			
74HCT245N	–40 °C to +125 °C	DIP20	plastic dual in-line package; 20 leads (300 mil)	SOT146-1			
74HCT245D	–40 °C to +125 °C	SO20	plastic small outline package; 20 leads; body width 7.5 mm	SOT163-1			
74HCT245PW	–40 °C to +125 °C	TSSOP20	plastic thin shrink small outline package; 20 leads; body width 4.4 mm	SOT360-1			
74HCT245DB	–40 °C to +125 °C	SSOP20	plastic shrink small outline package; 20 leads; body width 5.3 mm	SOT339-1			
74HCT245BQ	–40 °C to +125 °C	DHVQFN20	plastic dual-in-line compatible thermal enhanced very thin quad flat package no leads; 20 terminals; body $2.5\times4.5\times0.85$ mm	SOT764-1			

## 5. Functional diagram



### 6. Pinning information

#### 6.1 Pinning



#### 6.2 Pin description

Table 3: Pin description

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Symbol	Pin	Description
DIR	1	direction control
A0	2	data input/output
A1	3	data input/output
A2	4	data input/output
A3	5	data input/output
A4	6	data input/output
A5	7	data input/output
A6	8	data input/output
A7	9	data input/output
GND	10	ground (0 V)
B7	11	data input/output
B6	12	data input/output
B5	13	data input/output
B4	14	data input/output
В3	15	data input/output
B2	16	data input/output

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Table 3: Pin description ...continued

Symbol	Pin	Description
B1	17	data input/output
B0	18	data input/output
ŌĒ	19	output enable input (active LOW)
$V_{CC}$	20	supply voltage

## 7. Functional description

#### 7.1 Function table

Table 4: Function table [1]

Input I		Input/output			
OE	DIR	An	Bn		
L	L	A = B	input		
L	Н	input	B = A		
Н	X	Z	Z		

<sup>[1]</sup> H = HIGH voltage level;

### 8. Limiting values

Table 5: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
$V_{CC}$	supply voltage			-0.5	+7	V
I <sub>IK</sub>	input diode current	$V_I < -0.5 \text{ V or } V_I > V_{CC} + 0.5 \text{ V}$		-	±20	mΑ
I <sub>OK</sub>	output diode current	$V_O < -0.5 \text{ V or} $ $V_O > V_{CC} + 0.5 \text{ V} $		-	±20	mA
I <sub>O</sub>	output source or sink current	$V_O = -0.5 \text{ V to } V_{CC} + 0.5 \text{ V}$		-	±35	mA
$I_{CC}$ , $I_{GND}$	V <sub>CC</sub> or GND current			-	±70	mΑ
T <sub>stg</sub>	storage temperature			-65	+150	°C
P <sub>tot</sub>	total power dissipation		<u>[1]</u>			
	DIP20 package			-	750	mW
	SO20, SSOP20, TSSOP20 and DHVQFN20 packages			-	500	mW

<sup>[1]</sup> For DIP20 packages: above 70 °C,  $P_{tot}$  derates linearly with 12 mW/K.

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L = LOW voltage level;

X = don't care:

Z = high-impedance OFF-state.

For SO20 packages: above 70  $^{\circ}\text{C},\,\text{P}_{\text{tot}}$  derates linearly with 8 mW/K.

For SSOP20 and TSSOP20 packages: above 60  $^{\circ}$ C, Ptot derates linearly with 5.5 mW/K.

For DHVQFN20 packages: above 60 °C, Ptot derates linearly with 4.5 mW/K.

### 9. Recommended operating conditions

Table 6: Recommended operating conditions

		3 11 3							
Symbol	Parameter	Conditions	Min	Тур	Max	Unit			
Type 74H	Type 74HC245								
V <sub>CC</sub>	supply voltage		2.0	5.0	6.0	V			
VI	input voltage		0	-	$V_{CC}$	V			
Vo	output voltage		0	-	$V_{CC}$	V			
t <sub>r</sub> , t <sub>f</sub>	input rise and fall	$V_{CC} = 2.0 \text{ V}$	-	-	1000	ns			
	times	V <sub>CC</sub> = 4.5 V	-	6.0	500	ns			
		$V_{CC} = 6.0 \text{ V}$	-	-	400	ns			
T <sub>amb</sub>	ambient temperature	Э	-40	-	+125	°C			
Type 74H	CT245								
V <sub>CC</sub>	supply voltage		4.5	5.0	5.5	V			
VI	input voltage		0	-	$V_{CC}$	V			
Vo	output voltage		0	-	$V_{CC}$	V			
t <sub>r</sub> , t <sub>f</sub>	input rise and fall times	$V_{CC} = 4.5 \text{ V}$	-	6.0	500	ns			
T <sub>amb</sub>	ambient temperature	Э	-40	-	+125	°C			

### 10. Static characteristics

Table 7: Static characteristics type 74HC245

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
T <sub>amb</sub> = 25	°C					
$V_{IH}$	HIGH-level input voltage	V <sub>CC</sub> = 2.0 V	1.5	1.2	-	V
		V <sub>CC</sub> = 4.5 V	3.15	2.4	-	V
		V <sub>CC</sub> = 6.0 V	4.2	3.2	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 2.0 V	-	0.8	0.5	V
		V <sub>CC</sub> = 4.5 V	-	2.1	1.35	V
		V <sub>CC</sub> = 6.0 V	-	2.8	1.8	V
V <sub>OH</sub>	HIGH-level output voltage	$V_I = V_{IH}$ or $V_{IL}$				
		$I_{O} = -20 \mu A; V_{CC} = 2.0 V$	1.9	2.0	-	V
		$I_{O} = -20 \mu A$ ; $V_{CC} = 4.5 V$	4.4	4.5	-	V
		$I_{O} = -20 \mu A; V_{CC} = 6.0 V$	5.9	6.0	-	V
		$I_{O} = -6.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.98	4.32	-	V
		$I_{O} = -7.8 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.48	5.81	-	V

 Table 7:
 Static characteristics type 74HC245 ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Uni
V <sub>OL</sub>	LOW-level output voltage	$V_I = V_{IH}$ or $V_{IL}$				
		$I_O = 20 \mu A; V_{CC} = 2.0 V$	-	0	0.1	V
		$I_O = 20 \mu A; V_{CC} = 4.5 V$	-	0	0.1	V
		$I_O = 20 \mu A; V_{CC} = 6.0 \text{ V}$	-	0	0.1	V
		$I_{O} = 6.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	0.15	0.26	V
		$I_O = 7.8 \text{ mA}; V_{CC} = 6.0 \text{ V}$	-	0.16	0.26	V
LI	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$	-	-	±0.1	μΑ
oz	OFF-state output current	$V_{I}$ = $V_{IH}$ or $V_{IL}$ ; $V_{O}$ = $V_{CC}$ or GND; $V_{CC}$ = 6.0 $V$	-	-	±0.5	μΑ
СС	quiescent supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 6.0 \text{ V}$	-	-	8.0	μΑ
Cı	input capacitance		-	3.5	-	pF
C <sub>I/O</sub>	input/output capacitance		-	10	-	pF
$\Gamma_{amb} = -40$	0 °C to +85 °C					
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 2.0 V	1.5	-	-	V
		V <sub>CC</sub> = 4.5 V	3.15	-	-	V
		V <sub>CC</sub> = 6.0 V	4.2	-	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 2.0 V	-	-	0.5	V
		V <sub>CC</sub> = 4.5 V	-	-	1.35	V
		V <sub>CC</sub> = 6.0 V	-	-	1.8	V
√oн	HIGH-level output voltage	$V_I = V_{IH}$ or $V_{IL}$				
		$I_{O} = -20 \mu A; V_{CC} = 2.0 V$	1.9	-	-	V
		$I_{O} = -20 \mu A; V_{CC} = 4.5 V$	4.4	-	-	V
		$I_{O} = -20 \mu A; V_{CC} = 6.0 V$	5.9	-	-	V
		$I_{O} = -6.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.84	-	-	V
		$I_{O} = -7.8 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.34	-	-	V
√ <sub>OL</sub>	LOW-level output voltage	$V_I = V_{IH}$ or $V_{IL}$				
		$I_O = 20 \mu A; V_{CC} = 2.0 V$	-	-	0.1	V
		$I_O = 20 \mu A; V_{CC} = 4.5 V$	-	-	0.1	V
		$I_O = 20 \mu A; V_{CC} = 6.0 V$	-	-	0.1	V
		$I_{O} = 6.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	-	0.33	V
		$I_{O} = 7.8 \text{ mA}; V_{CC} = 6.0 \text{ V}$	-	-	0.33	V
П	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$	-	-	±1.0	μΑ
OZ	OFF-state output current	$V_I = V_{IH}$ or $V_{IL}$ ; $V_O = V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$	-	-	±5.0	μΑ
cc	quiescent supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 6.0 \text{ V}$	-	-	80	μΑ
$\Gamma_{amb} = -40$	) °C to +125 °C					
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 2.0 V	1.5	-	-	V
		V <sub>CC</sub> = 4.5 V	3.15	-	-	V
		$V_{CC} = 6.0 \text{ V}$	4.2	-	-	V



At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{IL}$	LOW-level input voltage	V <sub>CC</sub> = 2.0 V	-	-	0.5	V
		V <sub>CC</sub> = 4.5 V	-	-	1.35	V
		V <sub>CC</sub> = 6.0 V	-	-	1.8	V
V <sub>OH</sub>	HIGH-level output voltage	$V_I = V_{IH}$ or $V_{IL}$		-		
		$I_{O} = -20 \mu A; V_{CC} = 2.0 V$	1.9	-	-	V
		$I_{O} = -20 \mu A; V_{CC} = 4.5 V$	4.4	-	-	V
		$I_{O} = -20 \mu A; V_{CC} = 6.0 V$	5.9	-	-	V
		$I_{O} = -6.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.7	-	-	V
		$I_{O} = -7.8 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.2	-	-	V
V <sub>OL</sub>	LOW-level output voltage	$V_I = V_{IH}$ or $V_{IL}$		-		
		$I_{O} = 20 \mu A; V_{CC} = 2.0 V$	-	-	0.1	V
		$I_{O} = 20 \mu A; V_{CC} = 4.5 V$	-	-	0.1	V
		$I_{O} = 20 \mu A; V_{CC} = 6.0 \text{ V}$	-	-	0.1	V
		$I_{O} = 6.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	-	0.4	V
		$I_{O} = 7.8 \text{ mA}; V_{CC} = 6.0 \text{ V}$	-	-	0.4	V
ILI	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$	-	-	±1.0	μΑ
l <sub>OZ</sub>	OFF-state output current	$V_I = V_{IH}$ or $V_{IL}$ ; $V_O = V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$	-	-	±10.0	μΑ
lcc	quiescent supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 6.0 \text{ V}$	-	-	160	μΑ

#### Table 8: Static characteristics type 74HCT245

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
T <sub>amb</sub> = 25	°C					
V <sub>IH</sub>	HIGH-level input voltage	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	2.0	1.6	-	V
V <sub>IL</sub>	LOW-level input voltage	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	-	1.2	0.8	V
V <sub>OH</sub>	HIGH-level output voltage	$V_I = V_{IH}$ or $V_{IL}$ ; $V_{CC} = 4.5 \text{ V}$				
		$I_{O} = -20 \mu A$	4.4	4.5	-	V
		$I_O = -6 \text{ mA}$	3.98	4.32	-	V
V <sub>OL</sub>	LOW-level output voltage	$V_I = V_{IH}$ or $V_{IL}$ ; $V_{CC} = 4.5 \text{ V}$				
		I <sub>O</sub> = 20 μA	-	0	0.1	V
		I <sub>O</sub> = 6.0 mA	-	0.15	0.26	V
ILI	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$	-	-	±0.1	μΑ
l <sub>OZ</sub>	OFF-state output current	$V_I = V_{IH}$ or $V_{IL}$ ; $V_{CC} = 5.5 \text{ V}$ ; $V_O = V_{CC}$ or GND per input pin; other inputs at $V_{CC}$ or GND; $I_O = 0 \text{ A}$	-	-	±0.5	μΑ
I <sub>CC</sub>	quiescent supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 5.5 \text{ V}$	-	-	8.0	μΑ



At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
∆l <sub>CC</sub>	additional quiescent supply current per input pin	$V_I = V_{CC} - 2.1$ V; other inputs at $V_I = V_{CC}$ or GND; $V_{CC} = 4.5$ V to 5.5 V; $I_O = 0$ A				
	An or Bn inputs		-	40	144	μΑ
	OE input		-	150	540	μΑ
	DIR input		-	90	324	μΑ
Cı	input capacitance		-	3.5	-	pF
C <sub>I/O</sub>	input/output capacitance		-	10	-	рF
$T_{amb} = -40$	0 °C to +85 °C					
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	2.0	-	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	-	-	8.0	V
√oH	HIGH-level output voltage	$V_I = V_{IH}$ or $V_{IL}$ ; $V_{CC} = 4.5 \text{ V}$				
		I <sub>O</sub> = -20 μA	4.4	-	-	V
		$I_O = -6 \text{ mA}$	3.84	-	-	V
/ <sub>OL</sub>	LOW-level output voltage	$V_I = V_{IH}$ or $V_{IL}$ ; $V_{CC} = 4.5 \text{ V}$				
		I <sub>O</sub> = 20 μA	-	-	0.1	V
		I <sub>O</sub> = 6.0 mA	-	-	0.33	V
LI	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$	-	-	±1.0	μΑ
OZ	OFF-state output current	$V_I = V_{IH}$ or $V_{IL}$ ; $V_{CC} = 5.5$ V; $V_O = V_{CC}$ or GND per input pin; other inputs at $V_{CC}$ or GND; $I_O = 0$ A	-	-	±5.0	μΑ
СС	quiescent supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 5.5 \text{ V}$	-	-	80	μΑ
∕l <sup>CC</sup>	additional quiescent supply current per input pin	$V_I = V_{CC} - 2.1$ V; other inputs at $V_I = V_{CC}$ or GND; $V_{CC} = 4.5$ V to 5.5 V; $I_O = 0$ A				
	An or Bn inputs		-	-	180	μΑ
	OE input		-	-	675	μΑ
	DIR input		-	-	405	μΑ
Γ <sub>amb</sub> = -40	0 °C to +125 °C					
/ <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	2.0	-	-	V
/ <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	-	-	0.8	V
√ <sub>OH</sub>	HIGH-level output voltage	$V_I = V_{IH}$ or $V_{IL}$ ; $V_{CC} = 4.5 \text{ V}$				
		I <sub>O</sub> = -20 μA	4.4	-	-	V
		$I_O = -6 \text{ mA}$	3.7	-	-	V
/ <sub>OL</sub>	LOW-level output voltage	$V_I = V_{IH}$ or $V_{IL}$ ; $V_{CC} = 4.5 \text{ V}$				
<i>y</i> <del>-</del>		I <sub>O</sub> = 20 μA	-	-	0.1	V
		I <sub>O</sub> = 6.0 mA	-	-	0.4	V
LI	input leakage current	$V_{I} = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$	-	-	±1.0	μΑ
loz	OFF-state output current	$V_I = V_{IH}$ or $V_{IL}$ ; $V_{CC} = 5.5 \text{ V}$ ; $V_O = V_{CC}$ or GND per input pin; other inputs at $V_{CC}$ or GND; $I_O = 0 \text{ A}$	-	-	±10	μΑ

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At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I <sub>CC</sub>	quiescent supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 5.5 \text{ V}$	-	-	160	μΑ
Δl <sub>CC</sub>	additional quiescent supply current per input pin	$V_I = V_{CC} - 2.1$ V; other inputs at $V_I = V_{CC}$ or GND; $V_{CC} = 4.5$ V to 5.5 V; $I_O = 0$ A				
	An or Bn inputs		-	-	196	μΑ
	OE input		-	-	735	μΑ
	DIR input		-	-	441	μΑ

## 11. Dynamic characteristics

Table 9: Dynamic characteristics type 74HC245

GND = 0 V; test circuit see Figure 7.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
T <sub>amb</sub> = 25 °	°C					
t <sub>PHL</sub> , t <sub>PLH</sub>	propagation delay An to Bn or Bn	see Figure 5				
	to An	V <sub>CC</sub> = 2.0 V	-	25	90	ns
		V <sub>CC</sub> = 4.5 V	-	9	18	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	-	7	-	ns
		$V_{CC} = 6.0 \text{ V}$	-	7	15	ns
t <sub>PZH</sub> , t <sub>PZL</sub>	3-state output enable time OE to	see Figure 6				
	An or $\overline{OE}$ to Bn	V <sub>CC</sub> = 2.0 V	-	30	150	ns
		V <sub>CC</sub> = 4.5 V	-	11	30	ns
		V <sub>CC</sub> = 6.0 V	-	9	26	ns
t <sub>PHZ</sub> , t <sub>PLZ</sub>	3-state output disable time OE to	see Figure 6				
	An or $\overline{OE}$ to Bn	V <sub>CC</sub> = 2.0 V	-	41	150	ns
		V <sub>CC</sub> = 4.5 V	-	15	30	ns
		V <sub>CC</sub> = 6.0 V	-	12	26	ns
t <sub>THL</sub> , t <sub>TLH</sub>	output transition time	see Figure 5				
		V <sub>CC</sub> = 2.0 V	-	14	60	ns
		V <sub>CC</sub> = 4.5 V	-	5	12	ns
		V <sub>CC</sub> = 6.0 V	-	4	10	ns
C <sub>PD</sub>	power dissipation capacitance per transceiver	$V_I = GND \text{ to } V_{CC}$	[1] -	30	-	pF
T <sub>amb</sub> = -40	°C to +85 °C					
t <sub>PHL</sub> , t <sub>PLH</sub>	propagation delay An to Bn or Bn	see Figure 5				
	to An	V <sub>CC</sub> = 2.0 V	-	-	115	ns
		V <sub>CC</sub> = 4.5 V	-	-	23	ns
		V <sub>CC</sub> = 6.0 V	-	-	20	ns



Symbol	Parameter	Conditions	Min	Тур	Max	Uni
t <sub>PZH</sub> , t <sub>PZL</sub>	3-state output enable time OE to	see Figure 6				
	An or OE to Bn	V <sub>CC</sub> = 2.0 V	-	-	190	ns
		V <sub>CC</sub> = 4.5 V	-	-	38	ns
		V <sub>CC</sub> = 6.0 V	-	-	33	ns
t <sub>PHZ</sub> , t <sub>PLZ</sub>	3-state output disable time OE to	see Figure 6				
	An or OE to Bn	V <sub>CC</sub> = 2.0 V	-	-	190	ns
		V <sub>CC</sub> = 4.5 V	-	-	38	ns
		V <sub>CC</sub> = 6.0 V	-	-	33	ns
t <sub>THL</sub> , t <sub>TLH</sub>	output transition time	see Figure 5				
		V <sub>CC</sub> = 2.0 V	-	-	75	ns
		V <sub>CC</sub> = 4.5 V	-	-	15	ns
		V <sub>CC</sub> = 6.0 V	-	-	13	ns
T <sub>amb</sub> = -40	°C to +125 °C					
t <sub>PHL</sub> , t <sub>PLH</sub>	propagation delay An to Bn or Bn to An	see Figure 5				
		V <sub>CC</sub> = 2.0 V	-	-	135	ns
		V <sub>CC</sub> = 4.5 V	-	-	27	ns
		V <sub>CC</sub> = 6.0 V	-	-	23	ns
t <sub>PZH</sub> , t <sub>PZL</sub>	3-state output enable time OE to	see Figure 6				
	An or $\overline{OE}$ to Bn	V <sub>CC</sub> = 2.0 V	-	-	225	ns
		V <sub>CC</sub> = 4.5 V	-	-	45	ns
		V <sub>CC</sub> = 6.0 V	-	-	38	ns
t <sub>PHZ</sub> , t <sub>PLZ</sub>	3-state output disable time OE to	see Figure 6				
	An or $\overline{OE}$ to Bn	V <sub>CC</sub> = 2.0 V	-	-	225	ns
		$V_{CC} = 4.5 \text{ V}$	-	-	45	ns
		V <sub>CC</sub> = 6.0 V	-	-	38	ns
t <sub>THL</sub> , t <sub>TLH</sub>	output transition time	see Figure 5				
		V <sub>CC</sub> = 2.0 V	-	-	90	ns
		V <sub>CC</sub> = 4.5 V	-	-	18	ns
		V <sub>CC</sub> = 6.0 V	-	-	15	ns

<sup>[1]</sup>  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ):

 $P_D = C_{PD} \times V_{CC}{}^2 \times f_i \times N + \sum (C_L \times V_{CC}{}^2 \times f_o) \text{ where:}$ 

 $f_i$  = input frequency in MHz;

 $f_o$  = output frequency in MHz;

C<sub>L</sub> = output load capacitance in pF;

V<sub>CC</sub> = supply voltage in V;

N = number of inputs switching;

 $\sum (C_L \times V_{CC}^2 \times f_o)$  = sum of outputs.

Table 10: Dynamic characteristics type 74HCT245

GND = 0 V; test circuit see Figure 7.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
T <sub>amb</sub> = 25	C					
t <sub>PHL</sub> , t <sub>PLH</sub>	propagation delay An to Bn or Bn	see Figure 5				
	to An	$V_{CC} = 4.5 \text{ V}$	-	12	22	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	-	10	-	ns
$t_{PZH}$ , $t_{PZL}$	3-state output enable time $\overline{\text{OE}}$ to An or $\overline{\text{OE}}$ to Bn	V <sub>CC</sub> = 4.5 V; see <u>Figure 6</u>	-	16	30	ns
t <sub>PHZ</sub> , t <sub>PLZ</sub>	3-state output disable time $\overline{\text{OE}}$ to An or $\overline{\text{OE}}$ to Bn	V <sub>CC</sub> = 4.5 V; see <u>Figure 6</u>	-	16	30	ns
t <sub>THL</sub> , t <sub>TLH</sub>	output transition time	V <sub>CC</sub> = 4.5 V; see Figure 5	-	5	12	ns
C <sub>PD</sub>	power dissipation capacitance per transceiver	$V_I = GND \text{ to } V_{CC} - 1.5 \text{ V}$	<u>[1]</u> -	30	-	pF
T <sub>amb</sub> = -40	°C to +85 °C					
t <sub>PHL</sub> , t <sub>PLH</sub>	propagation delay An to Bn or Bn to An	V <sub>CC</sub> = 4.5 V; see <u>Figure 5</u>	-	-	28	ns
t <sub>PZH</sub> , t <sub>PZL</sub>	3-state output enable time $\overline{\text{OE}}$ to An or $\overline{\text{OE}}$ to Bn	V <sub>CC</sub> = 4.5 V; see <u>Figure 6</u>	-	-	38	ns
$t_{PHZ}, t_{PLZ}$	3-state output disable time $\overline{\text{OE}}$ to An or $\overline{\text{OE}}$ to Bn	V <sub>CC</sub> = 4.5 V; see <u>Figure 6</u>	-	-	38	ns
t <sub>THL</sub> , t <sub>TLH</sub>	output transition time	V <sub>CC</sub> = 4.5 V; see Figure 5	-	-	15	ns
T <sub>amb</sub> = -40	°C to +125 °C					
t <sub>PHL</sub> , t <sub>PLH</sub>	propagation delay An to Bn or Bn to An	V <sub>CC</sub> = 4.5 V; see <u>Figure 5</u>	-	-	33	ns
t <sub>PZH</sub> , t <sub>PZL</sub>	3-state output enable time $\overline{OE}$ to An or $\overline{OE}$ to Bn	V <sub>CC</sub> = 4.5 V; see <u>Figure 6</u>	-	-	45	ns
t <sub>PHZ</sub> , t <sub>PLZ</sub>	3-state output disable time $\overline{\text{OE}}$ to An or $\overline{\text{OE}}$ to Bn	V <sub>CC</sub> = 4.5 V; see <u>Figure 6</u>	-	-	45	ns
t <sub>THL</sub> , t <sub>TLH</sub>	output transition time	V <sub>CC</sub> = 4.5 V; see Figure 5	-	-	18	ns

<sup>[1]</sup>  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ):

 $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum (C_L \times V_{CC}^2 \times f_o) \text{ where:}$ 

f<sub>i</sub> = input frequency in MHz;

f<sub>o</sub> = output frequency in MHz;

C<sub>L</sub> = output load capacitance in pF;

V<sub>CC</sub> = supply voltage in V;

N = number of inputs switching;

 $\sum (C_L \times V_{CC}^2 \times f_o) = \text{sum of outputs.}$ 

#### 12. Waveforms

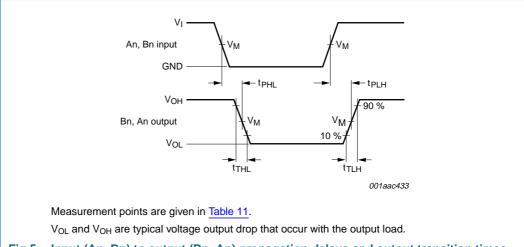
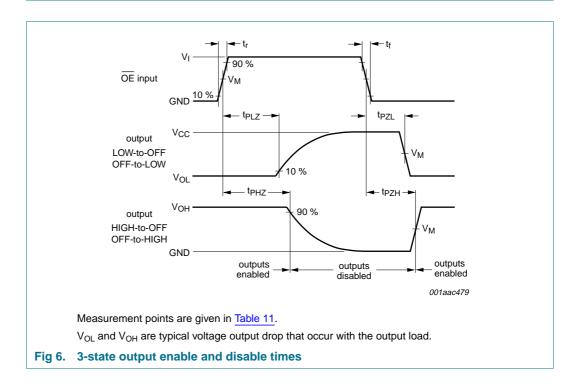


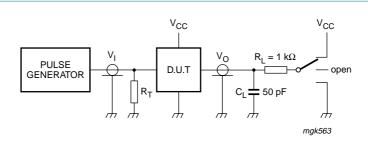
Fig 5. Input (An, Bn) to output (Bn, An) propagation delays and output transition times



**Table 11: Measurement points** 

Туре	Input	Output
	V <sub>M</sub>	V <sub>M</sub>
74HC245	0.5V <sub>CC</sub>	0.5V <sub>CC</sub>
74HCT245	1.3 V	1.3 V

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Test data is given in Table 12.

Definitions test circuit:

 $R_T$  = Termination resistance should be equal to output impedance  $Z_0$  of the pulse generator.

 $C_L$  = Load capacitance including jig and probe capacitance.

R<sub>L</sub> = Load resistor.

Fig 7. Load circuitry for switching times

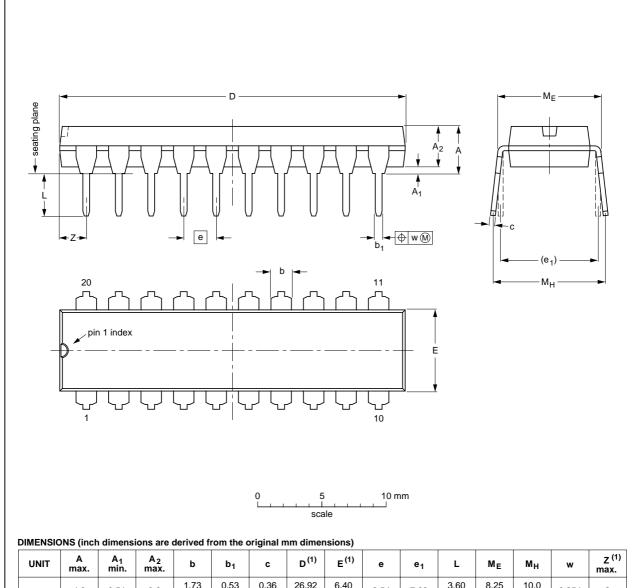
Table 12: Test data

Туре	Input		Test	Test					
	VI	t <sub>r</sub> , t <sub>f</sub>	t <sub>PHL</sub> , t <sub>PLH</sub>	t <sub>PZH</sub> , t <sub>PHZ</sub>	t <sub>PZL</sub> , t <sub>PLZ</sub>				
74HC245	$V_{CC}$	6 ns	open	GND	V <sub>CC</sub>				
74HCT245	3 V	6 ns	open	GND	V <sub>CC</sub>				

### 13. Package outline

#### DIP20: plastic dual in-line package; 20 leads (300 mil)

SOT146-1



	•					•									
UNIT	A max.	A <sub>1</sub> min.	A <sub>2</sub> max.	b	b <sub>1</sub>	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	e <sub>1</sub>	L	ME	Мн	w	Z <sup>(1)</sup> max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	0.36 0.23	26.92 26.54	6.40 6.22	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2
inches	0.17	0.02	0.13	0.068 0.051	0.021 0.015	0.014 0.009	1.060 1.045	0.25 0.24	0.1	0.3	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.078

#### Note

1. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

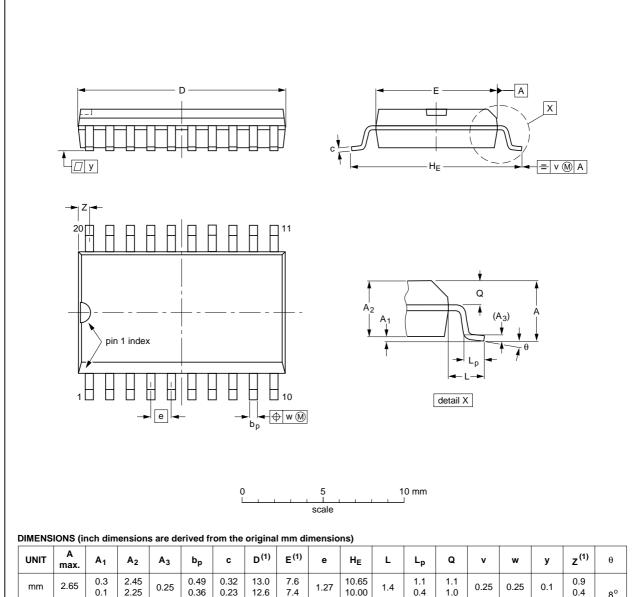
PROJECTION ISSUE DATE	
99-12-27 03-02-13	
_	99-12-27

Fig 8. Package outline SOT146-1 (DIP20)

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#### SO20: plastic small outline package; 20 leads; body width 7.5 mm

#### SOT163-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	HE	L	Lp	Q	v	w	у	z <sup>(1)</sup>	θ
mm	2.65	0.3 0.1	2.45 2.25	0.25	0.49 0.36	0.32 0.23	13.0 12.6	7.6 7.4	1.27	10.65 10.00	1.4	1.1 0.4	1.1 1.0	0.25	0.25	0.1	0.9 0.4	8°
inches	0.1	0.012 0.004	0.096 0.089	0.01	0.019 0.014		0.51 0.49	0.30 0.29	0.05	0.419 0.394	0.055	0.043 0.016		0.01	0.01	0.004	0.035 0.016	0°

#### Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

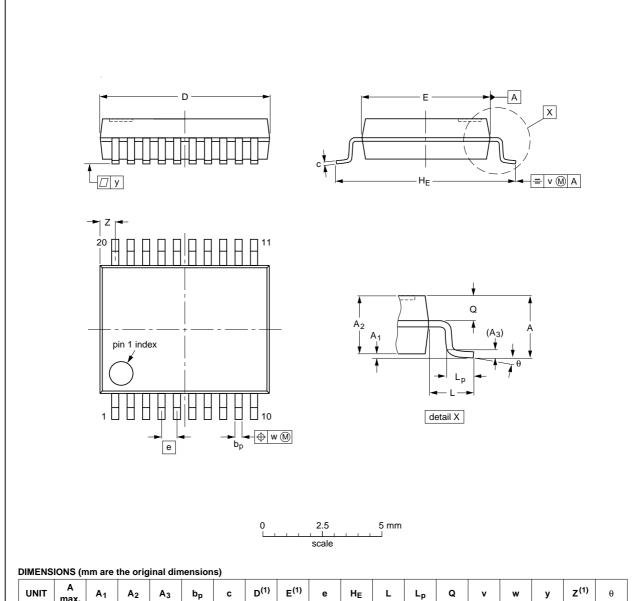
OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT163-1	075E04	MS-013				<del>99-12-27</del> 03-02-19

Fig 9. Package outline SOT163-1 (SO20)

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#### SSOP20: plastic shrink small outline package; 20 leads; body width 5.3 mm

SOT339-1



-				3			-,												
	UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	HE	L	Lp	Q	v	w	у	Z <sup>(1)</sup>	θ
	mm	2	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	7.4 7.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	0.9 0.5	8° 0°

#### Note

1. Plastic or metal protrusions of 0.2 mm maximum per side are not included.

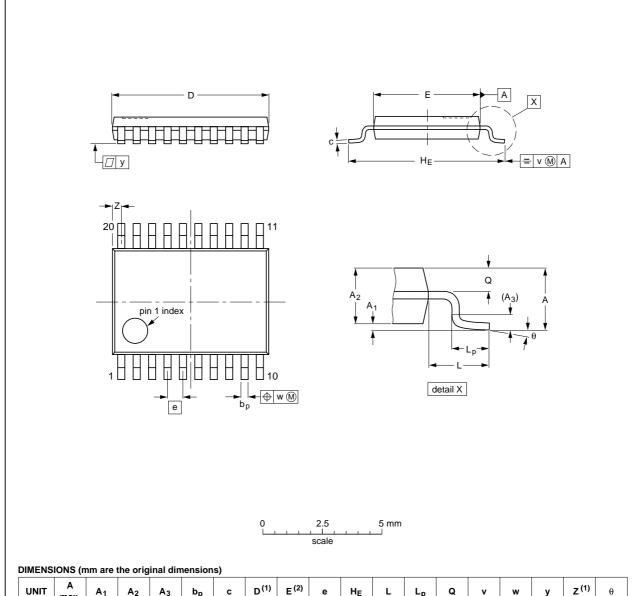
OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT339-1		MO-150				<del>99-12-27</del> 03-02-19	

Fig 10. Package outline SOT339-1 (SSOP20)

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#### TSSOP20: plastic thin shrink small outline package; 20 leads; body width 4.4 mm

SOT360-1



=							-,												
	UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(2)</sup>	е	HE	L	Lp	Q	v	w	у	Z <sup>(1)</sup>	θ
	mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	6.6 6.4	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.5 0.2	8° 0°

#### Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT360-1		MO-153				<del>99-12-27</del> 03-02-19	

Fig 11. Package outline SOT360-1 (TSSOP20)

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DHVQFN20: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 20 terminals; body 2.5 x 4.5 x 0.85 mm SOT764-1

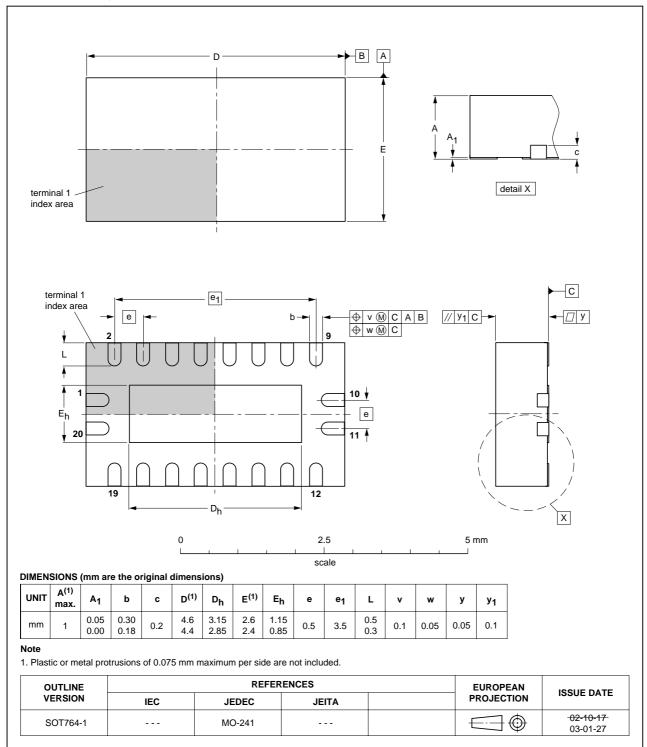


Fig 12. Package outline SOT764-1 (DHVQFN20)

9397 750 14502



## 14. Revision history

#### Table 13: Revision history

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes	
74HC_HCT245_3	20050131	Product data sheet	-	9397 750 14502	74HC_HCT245_CNV_2	
Modifications:	<ul> <li>The format of this data sheet is redesigned to comply with the new presentation and information standard of Philips Semiconductors</li> </ul>					
		"Ordering information in modified to include			and Section 13 "Package	
74HC_HCT245_CNV_2	19930930	Product specification	-	-	-	



Level	Data sheet status [1]	Product status [2] [3]	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
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- [1] Please consult the most recently issued data sheet before initiating or completing a design.
- [2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.
- [3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

#### 16. Definitions

**Short-form specification** — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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# 74HC245; 74HCT245

### **Philips Semiconductors**

Octal bus tranceiver; 3-state

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